Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
09/501,182	CHANG ET AL.
Examiner	Art Unit
Dave Czekaj	2613

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	240.16	5/13/2005	DC	
	<u></u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated Previous Search	5/13/2005	DC	